

## **BULB128-1**

# HIGH VOLTAGE FAST-SWITCHING NPN POWER TRANSISTOR

Ordering Code	Marking	Shipment		
BULB128-1	BULB128	Tube		

- STMicroelectronics PREFERRED SALESTYPE
- NPN TRANSISTOR
- HIGH VOLTAGE CAPABILITY
- LOW SPREAD OF DYNAMIC PARAMETERS
- MINIMUM LOT-TO-LOT SPREAD FOR RELIABLE OPERATION
- VERY HIGH SWITCHING SPEED
- THROUGH HOLE I<sup>2</sup>PAK (TO-262) POWER PACKAGE IN TUBE (SUFFIX "-1")

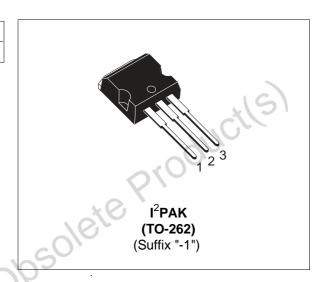


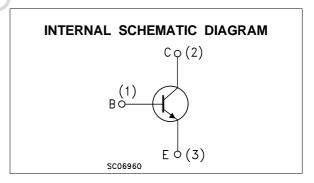
 ELECTRONIC BALLASTS FOR FLUORESCENT LIGHTING



The device is manufactured using high voltage Multi-Epitaxial Planar technology for high switching speeds and medium voltage capability. It uses a Cellular Emitter structure with planar edge termination to enhance switching speeds while maintaining the wide RBSOA.

The device is designed for use in lighting applications and low cost switch-mode power supplies.





#### ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V <sub>CES</sub>	Collector-Emitter Voltage (V <sub>BE</sub> = 0)	700	V
Vceo	Collector-Emitter Voltage (I <sub>B</sub> = 0)	400	V
V <sub>EBO</sub>	Emitter-Base Voltage (I <sub>C</sub> = 0)	9	V
Ic	Collector Current	4	А
I <sub>CM</sub>	Collector Peak Current (t <sub>p</sub> < 5 ms)	8	А
Ι <sub>Β</sub>	Base Current	2	А
I <sub>BM</sub>	Base Peak Current (t <sub>p</sub> < 5 ms)	4	А
P <sub>tot</sub>	Total Dissipation at T <sub>c</sub> = 25 °C	70	W
T <sub>stg</sub>	Storage Temperature	-65 to 150	°C
Tj	Max. Operating Junction Temperature	150	°C

September 2003 1/7

#### THERMAL DATA

R <sub>thj-case</sub>	Thermal Resistance Junction-Case	Max	1.78	°C/W
R <sub>thj-amb</sub>	Thermal Resistance Junction-Ambient	Max	62.5	°C/W

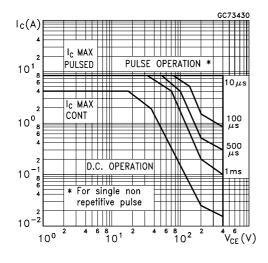
## **ELECTRICAL CHARACTERISTICS** ( $T_{case} = 25$ $^{\circ}C$ unless otherwise specified)

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Unit
I <sub>CES</sub>	Collector Cut-off Current (V <sub>BE</sub> = 0)	V <sub>CE</sub> = 700 V V <sub>CE</sub> = 700 V	T <sub>C</sub> = 125 °C			100 500	μA μA
V <sub>EBO</sub>	Emitter-Base Voltage (I <sub>C</sub> = 0)	I <sub>E</sub> = 10 mA		9			V
V <sub>CEO(sus)*</sub>	Collector-Emitter Sustaining Voltage (I <sub>B</sub> = 0)	I <sub>C</sub> = 100 mA	L = 25 mH	400		115	34
ICEO	Collector Cut-Off Current (I <sub>B</sub> = 0)	V <sub>CE</sub> = 400 V			9	250	μΑ
V <sub>CE(sat)</sub> *	Collector-Emitter Saturation Voltage	I <sub>C</sub> = 0.5 A I <sub>C</sub> = 1 A I <sub>C</sub> = 2.5 A I <sub>C</sub> = 4 A	I <sub>B</sub> = 0.1 A I <sub>B</sub> = 0.2 A I <sub>B</sub> = 0.5 A I <sub>B</sub> = 1 A	PI	0.5	0.7 1 1.5	V V V
V <sub>BE(sat)</sub> *	Base-Emitter Saturation Voltage	I <sub>C</sub> = 0.5 A I <sub>C</sub> = 1 A I <sub>C</sub> = 2.5 A	I <sub>B</sub> = 0.1 A I <sub>B</sub> = 0.2 A I <sub>B</sub> = 0.5 A			1.1 1.2 1.3	V V V
h <sub>FE</sub> *	DC Current Gain	I <sub>C</sub> = 10 mA I <sub>C</sub> = 2 A	V <sub>CE</sub> = 5 V V <sub>CE</sub> = 5 V	10 14		28	
t <sub>s</sub>	RESISTIVE LOAD Storage Time Fall Time	$V_{CC} = 125 \text{ V}$ $I_{B1} = 0.4 \text{ A}$ $T_p = 30  \mu \text{s}$	$I_C = 2 A$ $I_{B2} = -0.4 A$ (see fig.2)	1.5	0.2	3 0.4	μs μs
t <sub>s</sub>	INDUCTIVE LOAD Storage Time Fall Time	I <sub>C</sub> = 2 A V <sub>BE(off)</sub> = -5 V V <sub>clamp</sub> = 200 V	$I_{B1}$ = 0.4 A $R_{BB}$ = 0 $\Omega$ (see fig.1)		0.6 0.1	1 0.2	μs μs

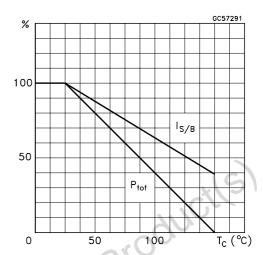
<sup>\*</sup> Pulsed: Pulse duration = 300 μs, duty cycle 1.5 %

2/7

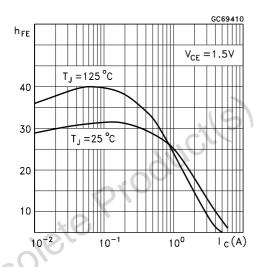
#### Safe Operating Areas



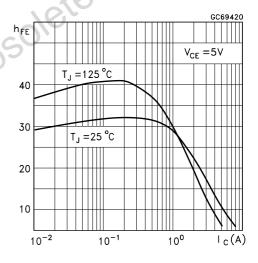
#### **Derating Curve**



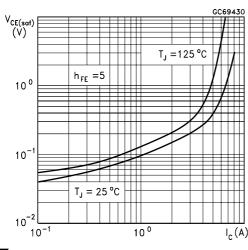
DC Current Gain



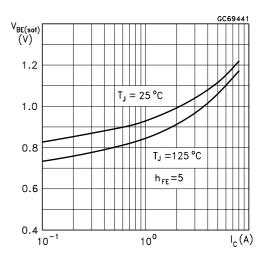
DC Current Gain



Collector Emitter Saturation Voltage

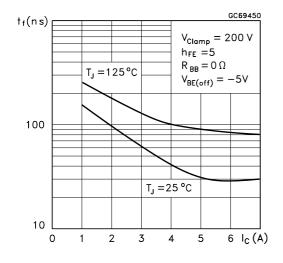


Base Emitter Saturation Voltage

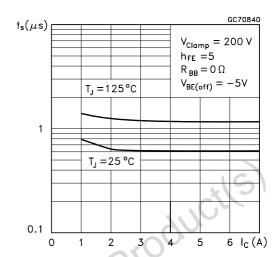


477

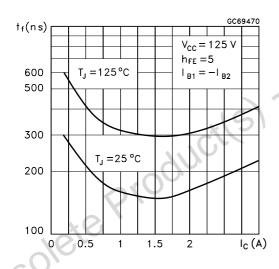
#### Inductive Fall Time



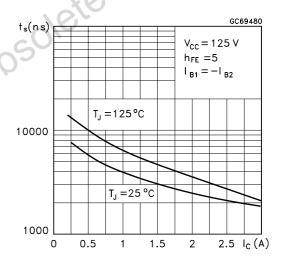
#### Inductive Storage Time



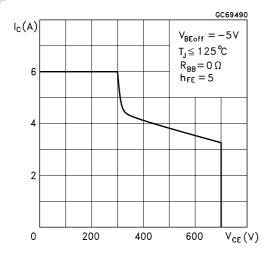
#### Resistive Fall Time



#### Resistive Load Storage Time



#### Reverse Biased SOA



4/7

Figure 1: Inductive Load Switching Test Circuit.

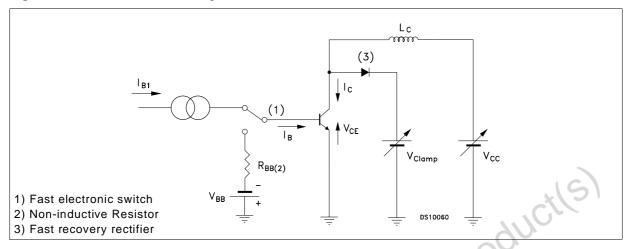
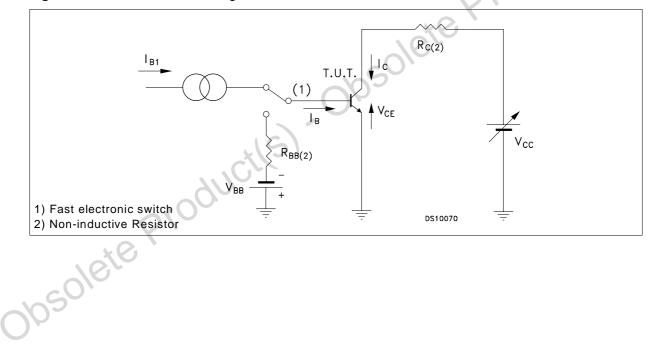
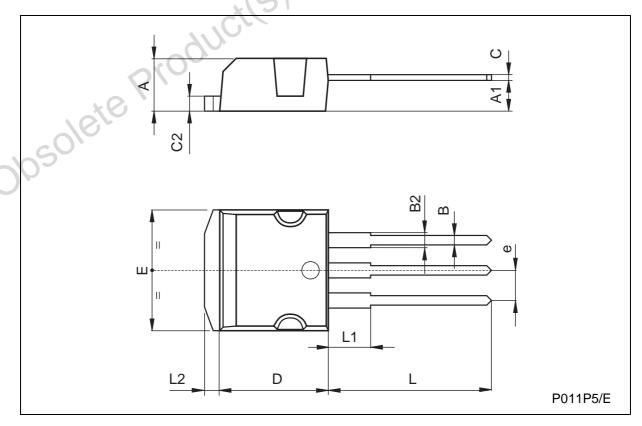


Figure 2: Resistive Load Switching Test Circuit.



# TO-262 (I<sup>2</sup>PAK) MECHANICAL DATA

DIM.	mm			inch		
Diiii.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А	4.4		4.6	0.173		0.181
A1	2.49		2.69	0.098		0.106
В	0.7		0.93	0.027		0.036
B2	1.14		1.7	0.044		0.067
С	0.45		0.6	0.017		0.023
C2	1.23		1.36	0.048	00,0	0.053
D	8.95		9.35	0.352	2/0	0.368
е	2.4		2.7	0.094		0.106
E	10		10.4	0.393		0.409
L	13.1		13.6	0.515		0.531
L1	3.48		3.78	0.137		0.149
L2	1.27		1.4	0.050		0.055



6/7

Obsolete Product(s). Obsolete Product(s)

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